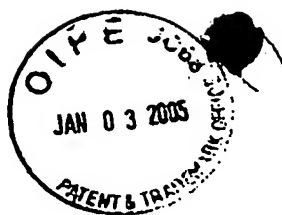


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>255595US3PCT</b>		SERIAL NO. <b>10/500,852</b>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Takashi SHIMIZU, et al.</b>			
				FILING DATE <b>July 16, 2004</b>		GROUP	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/DK/	AA	6 223 616	05/01/01	William G. SHERIDAN			
/DK/	AB	4 315 440	02/16/82	Siegfried CHSZANIECKI			
/DK/	AC	4 136 580	01/30/79	Wilhelm BRAND, et al.			
/DK/	AD	3 771 622	11/13/73	Hiroyuki HYAKUMURA			
/DK/	AE	6 223 858	05/01/01	Toshikazu UBAGAI, et al.			
	AF						
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	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
/DK/	AO	374 463	06/27/90	EP		NO	
/DK/	AP	2 173 486	10/05/73	FR		NO	
/DK/	AQ	681 298	10/22/52	GB		NO	
/DK/	AR	4-175542	06/23/92	JP(with English abstract)		NO	
/DK/	AS	2001-227625	08/24/01	JP(with English abstract)		NO	
/DK/	AT	7-217725	08/15/95	JP(with English abstract)		NO	
/DK/	AU	5-27413	04/09/93	JP(with partial English translation)		NO	
/DK/	AV	2001-182809	07/06/01	JP(with English abstract)		NO	
/DK/	AW	6-213306	08/02/94	JP(with English abstract)		NO	
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <b>/Derek Knight/</b>				Date Considered <b>09/04/2007</b>			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



**LIST OF RELATED CASES**

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent Appl. Publication No.</u>	<u>Inventor/ Applicant</u>
<del>255595US3 PCT*</del>	<del>10/500,852</del>	<del>07/16/04</del>	<del></del>	<del>SHIMIZU, et al.</del>
<del>259877US3</del>	<del>10/956,135</del>	<del>10/04/04</del>	<del></del>	<del>ICHIOKA, et al.</del>

/Derek Knight/

09/04/2007

\*Present Application; listed for information

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 255595US26PCT		SERIAL NO. 10/500,852	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takashi SHIMIZU, et al.			
				FILING DATE May 31, 2005		GROUP 3681	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
/DK/	AA	4,429,587	07Feb1984	George A. FINN, III et al.			
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<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/DK/	AO	JP 52-076871 U	08/08/1977	JAPAN	x		
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<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Derek Knight/		Date Considered 09/03/2007	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

255595US3PCT

SERIAL NO.

10/500,852

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takashi SHIMIZU, et al.

FILING DATE

May 31, 2005

GROUP

3681

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	AB					
	AC					
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	AI					
	AJ					
	AK					
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	AM					
	AN					

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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/DK/	AO	53-37883	04/03/1978	Japan (with partial English translation)	X	
/DK/	AP	55-173755	12/12/1980	Japan (with partial English translation)	X	
/DK/	AQ	57-110359	07/08/1982	Japan (with partial English translation)	X	
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/DK/	AS	59-208268	11/26/1984	Japan (with English abstract and partial English translation)	X	
/DK/	AT	6-107010	04/19/1994	Japan (with English abstract and partial English translation)	X	
/DK/	AU	7-54973	02/28/1995	Japan (with English abstract and partial English translation)	X	
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

/Derek Knight/

Date Considered

09/03/2007

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.